

Notice of References Cited	Application/Control No. 10/825,875	Applicant(s)/Patent Under Reexamination DEPAUW, JUSTIN L.	
	Examiner Anthony Weier	Art Unit 1761	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,127,569	10-2000	Dho et al.	560/41
	C	US-2002/0019557	02-2002	Prakash et al.	560/40
	D	US-5,308,494	05-1994	Brandon et al.	210/639
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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